MSKSEMI 美森科













ESD

TVS

TSS

MOV

GDT

PLED

AO3400A-MS

Product specification





Features

- 30V, 5.8 A, RDS(ON) = 20mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- Suit for 2.5V Gate Drive Applications

Application

- Notebook
- Load Switch
- LED applications

BVDSS	RDSON	ID
30V	20mΩ	5.8A

Reference News

PACKAGE OUTLINE	Pin Configuration	Marking
SOT-23	G	A09T

Absolute Maximum Ratings (TA=25 °C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±12	V
lo	Drain Current - Continuous (T _A =25°C)	5.8	A
	Drain Current - Continuous (T _A =70°C)	4.2	А
Ідм	Drain Current - Pulsed ¹	21.2	A
Po	Power Dissipation (T _A =25°C)	1.56	W
	Power Dissipation - Derate above 25°C	0.012	W/°C
Тятд	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 125	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	°C/W



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Id=250uA	30			V
△BV _{DSS} /△T _J	BVDss Temperature Coefficient	Reference to 25°C,I _D =1mA		0.06		V/°C
le e e	Drain Source Lookage Current	Vds=30V,Vgs=0V,Tj=25°C			1	uA
DSS	Drain-Source Leakage Current	V _D s=24V , V _G s=0V , T _J =125°C			10	uA
lgss	Gate-Source Leakage Current	$V_{GS} = \pm 12V$, $V_{DS} = 0V$			±100	nA
)n Charac	teristics					
		Vgs=10V,Ib=5A		20	30	
RDS(ON)	Static Drain-Source On-Resistance	Vgs=4.5V , Id=4A		23	33	mΩ
		Vgs=2.5V , Id=3A		30	55	
VGS(th)	Gate Threshold Voltage		0.5	0.9	1.2	V
${}^{\vartriangle}V$ GS(th)	VGs(th) Temperature Coefficient	─Vgs=Vps,Ip =250uA		-3		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , Is=3A		7		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}			8.4	
Qgs	Gate-Source Charge ^{2,3}	VDs=10V , VGs=4.5V , ID=4A		1	 nC
Qgd	Gate-Drain Charge ^{2,3}			2.2	
Td(on)	Turn-On Delay Time ^{2 , 3}			4.5	
Tr	Rise Time ^{2 , 3}	VDD=10V , VGs=4.5V , RG=25Ω Ib=1A		13	
Td(off)	Turn-Off Delay Time ^{2,3}			27	 nS
Tf	Fall Time ^{2 , 3}			8.3	
Ciss	Input Capacitance			695	
Coss	Output Capacitance	Vds=10V , Vgs=0V , F=1MHz		45	 pF
Crss	Reverse Transfer Capacitance			36	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions		Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V⊳=0V,Force Current			5.8	Α
lsм	Pulsed Source Current	vg-vb-ov, roice current			11.6	А
Vsd	Diode Forward Voltage	Vgs=0V,Is=1A,Tj=25°C			1.2	V

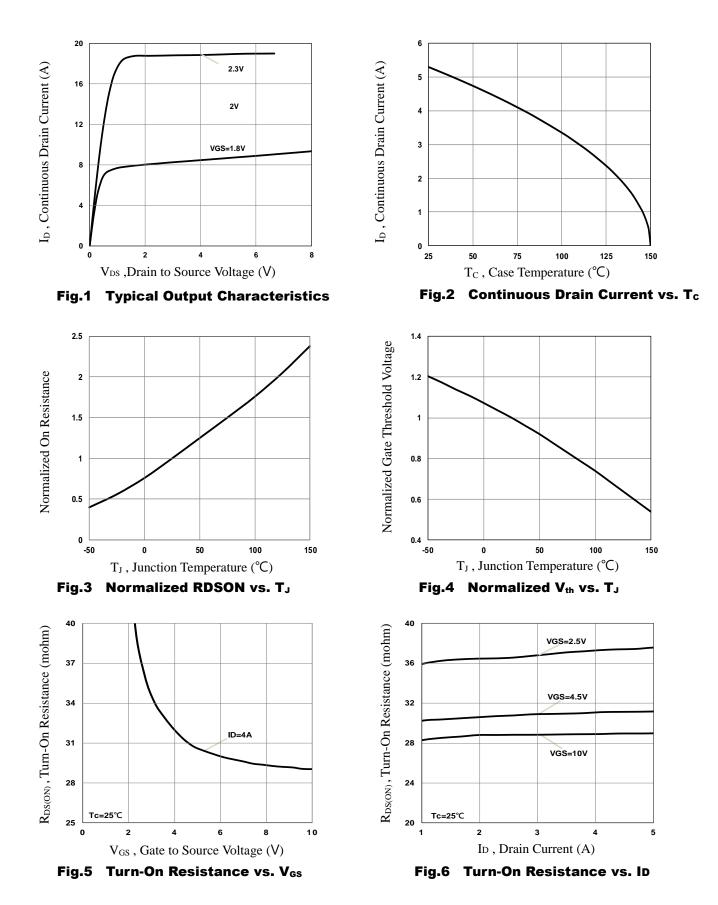
Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

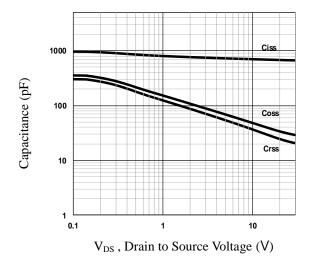
2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.

3. Essentially independent of operating temperature.











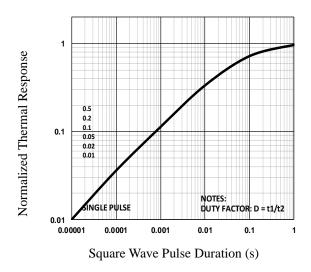


Fig.9 Normalized Transient Impedance

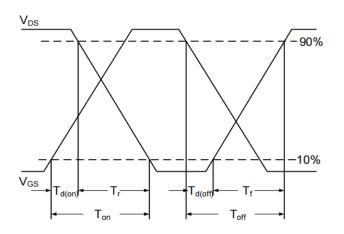


Fig.11 Switching Time Waveform

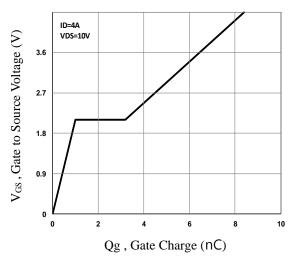


Fig.8 Gate Charge Characteristics

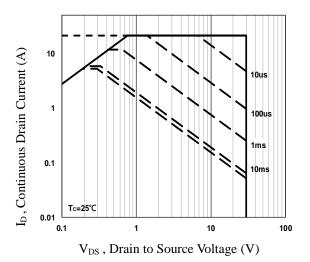


Fig.10 Maximum Safe Operation Area

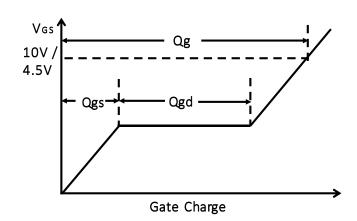
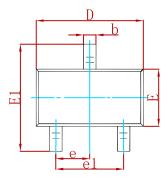
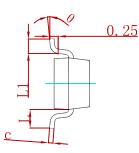
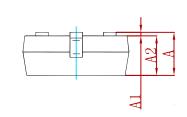


Fig.12 Gate Charge Waveform

PACKAGE MECHANICAL DATA

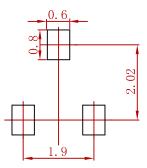






Symbol	Dimensions In Millimeters		Dimension	is in Inches
Symbol	Min	Max	Min	Max
А	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.95	0 TYP	0.03	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550	0.550 REF		2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note: 1.Controlling dimension:in millimeters. 2.General tolerance:±0.05mm. 3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AO3400A-MS	SOT-23	3000



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